



# Precision Transimpedance Logarithmic Amplifier with Over 5 Decades of Dynamic Range

## ABSOLUTE MAXIMUM RATINGS

(All voltages referenced to GND, unless otherwise noted.)

V <sub>CC</sub> .....	-0.3V to +12V
V <sub>EE</sub> .....	-6V to +0.3V
Supply Voltage (V <sub>CC</sub> to V <sub>EE</sub> ) .....	+12V
REFVOUT .....	(V <sub>EE</sub> - 0.3V) to +3.0V
OSADJ, SCALE, REFISET .....	(V <sub>EE</sub> - 0.3V) to +5.5V
REFIIN, LOGIIN .....	(V <sub>EE</sub> - 0.3V) to V <sub>CMVIN</sub>
LOGV1, LOGV2, CMVOUT, REFIOUT .....	(V <sub>EE</sub> - 0.3V) to (V <sub>CC</sub> + 0.3V)

CMVIN .....	(V <sub>EE</sub> - 0.3V) to +1V
Continuous Current (REFIIN, LOGIIN) .....	10mA
Continuous Power Dissipation (T <sub>A</sub> = +70°C) 16-Pin Thin QFN (derate 16.9mW/°C above +70°C) ....	1349mW
Operating Temperature Range .....	-40°C to +85°C
Junction Temperature .....	+150°C
Storage Temperature Range .....	-65°C to +150°C
Lead Temperature (soldering, 10s) .....	+300°C

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## DC ELECTRICAL CHARACTERISTICS—Single-Supply Operation

(V<sub>CC</sub> = +5V, V<sub>EE</sub> = GND = 0V, I<sub>REF</sub> = 1μA, I<sub>LOG</sub> = 10μA, LOGV2 = SCALE, LOGV1 = OSADJ, CMVIN = CMVOUT, R<sub>SET</sub> > 1MΩ, T<sub>A</sub> = -40°C to +85°C. Typical values are at T<sub>A</sub> = +25°C, unless otherwise noted.) (Note 1)

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNITS
Supply Voltage	V <sub>CC</sub>	(Note 2)		2.7		11.0	V
Supply Current	I <sub>CC</sub>	T <sub>A</sub> = +25°C			3.9	5	mA
		T <sub>A</sub> = -40°C to +85°C				7	
LOGIIN Current Range (Notes 3, 4)	I <sub>LOG</sub>	Minimum		10			nA
		Maximum				1	mA
REFIIN Current Range (Notes 3, 4)	I <sub>REF</sub>	Minimum		10			nA
		Maximum				1	mA
Common-Mode Voltage	V <sub>CMVOUT</sub>			480	500	520	mV
Common-Mode Voltage Input Range	V <sub>CMVIN</sub>			0.5		1.0	V
Log Conformity Error	V <sub>LC</sub>	I <sub>REF</sub> = 10nA, I <sub>LOG</sub> = 10nA to 1mA, K = 0.25V/decade (Note 4)	T <sub>A</sub> = +25°C		±2	±5	mV
			T <sub>A</sub> = -40°C to +85°C			±10	
Logarithmic Slope (Scale Factor)	K	T <sub>A</sub> = +25°C		237.5	250	262.5	mV/ decade
		T <sub>A</sub> = -40°C to +85°C (Note 4)		231.25		268.75	
Logarithmic Slope (Scale Factor) Temperature Drift		T <sub>A</sub> = -40°C to +85°C			80		μV/ decade/ °C
Input Offset Voltage	V <sub>IO</sub>	T <sub>A</sub> = +25°C,  V <sub>CMVIN</sub> - V <sub>REFIIN</sub>  ,  V <sub>CMVIN</sub> - V <sub>LOGIIN</sub>			1	5	mV
Input Offset Voltage Temperature Drift	V <sub>IOS</sub>	V <sub>CMVIN</sub> - V <sub>REFIIN</sub>  ,  V <sub>CMVIN</sub> - V <sub>LOGIIN</sub>			6		μV/°C
Voltage Reference Output	V <sub>REFVOUT</sub>	T <sub>A</sub> = +25°C		1.218	1.238	1.258	V
		T <sub>A</sub> = -40°C to +85°C (Note 4)		1.195		1.275	
Voltage Reference Output Current	I <sub>REFVOUT</sub>				1		mA
Current Reference Output Voltage	V <sub>REFISET</sub>	T <sub>A</sub> = +25°C		490	500	510	mV
		T <sub>A</sub> = -40°C to +85°C (Note 4)		482		518	

# Precision Transimpedance Logarithmic Amplifier with Over 5 Decades of Dynamic Range

MAX4206

## DC ELECTRICAL CHARACTERISTICS—Single-Supply Operation (continued)

( $V_{CC} = +5V$ ,  $V_{EE} = GND = 0V$ ,  $I_{REF} = 1\mu A$ ,  $I_{LOG} = 10\mu A$ ,  $LOGV2 = SCALE$ ,  $LOGV1 = OSADJ$ ,  $CMVIN = CMVOUT$ ,  $R_{SET} > 1M\Omega$ ,  $T_A = -40^\circ C$  to  $+85^\circ C$ . Typical values are at  $T_A = +25^\circ C$ , unless otherwise noted.) (Note 1)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
<b>LOGV2 BUFFER</b>						
Input Offset Voltage	$V_{IO}$	$T_A = +25^\circ C$		0.4	2	mV
		$T_A = -40^\circ C$ to $+85^\circ C$ (Note 4)			6	
Input Bias Current	$I_B$	(Note 4)		0.01	1	nA
Output Voltage Range	$V_{OH}$	$R_L$ to GND = $2k\Omega$		$V_{CC} - 0.2$	$V_{CC} - 0.3$	V
	$V_{OL}$	$R_L$ to GND = $2k\Omega$	0.2	0.08		
Output Short-Circuit Current	$I_{OUT+}$	Sourcing		34		mA
	$I_{OUT-}$	Sinking		58		
Slew Rate	SR			12		V/ $\mu s$
Unity-Gain Bandwidth	GBW			5		MHz

## AC ELECTRICAL CHARACTERISTICS—Single-Supply Operation

( $V_{CC} = +5V$ ,  $V_{EE} = GND = 0$ ,  $I_{REF} = 1\mu A$ ,  $I_{LOG} = 10\mu A$ ,  $LOGV2 = SCALE$ ,  $LOGV1 = OSADJ$ ,  $CMVIN = CMVOUT$ ,  $R_{SET} > 1M\Omega$ ,  $T_A = +25^\circ C$ , unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
LOGV2 Total Noise		0.1Hz to 10Hz, total output-referred noise, $I_{REF} = 10nA$ , $I_{LOG} = 100nA$		17		$\mu V_{RMS}$
LOGV2 Spot Noise Density		$f = 5kHz$ , $I_{REF} = 10nA$ , $I_{LOG} = 100nA$		0.8		$\mu V/\sqrt{Hz}$
REFVOUT Total Noise		1Hz to 10Hz, total output-referred noise		3.3		$\mu V_{RMS}$
REFVOUT Spot Noise Density		$f = 5kHz$		266		$nV/\sqrt{Hz}$
REFISET Total Noise		1Hz to 10Hz, total output-referred noise		0.67		$\mu V_{RMS}$
REFISET Spot Noise Density		$f = 5kHz$		23		$nV/\sqrt{Hz}$
Small-Signal Unity-Gain Bandwidth		$I_{REF} = 1\mu A$ , $I_{LOG} = 10\mu A$ , $R_{COMP} = 300\Omega$ , $C_{COMP} = 32pF$		1		MHz

## DC ELECTRICAL CHARACTERISTICS—Dual-Supply Operation

( $V_{CC} = +5V$ ,  $V_{EE} = -5V$ ,  $GND = 0$ ,  $I_{REF} = 1\mu A$ ,  $I_{LOG} = 10\mu A$ ,  $LOGV2 = SCALE$ ,  $LOGV1 = OSADJ$ ,  $CMVIN = CMVOUT$ ,  $R_{SET} > 1M\Omega$ ,  $T_A = -40^\circ C$  to  $+85^\circ C$ . Typical values are at  $T_A = +25^\circ C$ , unless otherwise noted.) (Note 1)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Supply Voltage (Note 2)	$V_{CC}$		2.7		5.5	V
	$V_{EE}$		-2.7		-5.5	
Supply Current	$I_{CC}$	$T_A = +25^\circ C$		5	6	mA
		$T_A = -40^\circ C$ to $+85^\circ C$			7.5	
LOGIIN Current Range (Notes 3, 4)	$I_{LOG}$	Minimum	10			nA
		Maximum			1	nA
REFIIN Current Range (Notes 3, 4)	$I_{REF}$	Minimum	10			nA
		Maximum			1	nA
Common-Mode Voltage	$V_{CMVOUT}$		480	500	520	mV

# Precision Transimpedance Logarithmic Amplifier with Over 5 Decades of Dynamic Range

## DC ELECTRICAL CHARACTERISTICS—Dual-Supply Operation (continued)

( $V_{CC} = +5V$ ,  $V_{EE} = -5V$ ,  $GND = 0$ ,  $I_{REF} = 1\mu A$ ,  $I_{LOG} = 10\mu A$ ,  $LOGV2 = SCALE$ ,  $LOGV1 = OSADJ$ ,  $CMVIN = CMVOUT$ ,  $R_{SET} > 1M\Omega$ ,  $T_A = -40^\circ C$  to  $+85^\circ C$ . Typical values are at  $T_A = +25^\circ C$ , unless otherwise noted.) (Note 1)

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNITS
Common-Mode Voltage Input Range	V <sub>CMVIN</sub>			0.5		1.0	V
Log Conformity Error	V <sub>LC</sub>	I <sub>REF</sub> = 10nA, I <sub>LOG</sub> = 10nA to 1mA, K = 0.25V/decade (Note 4)	T <sub>A</sub> = +25°C		±2	±5	mV
			T <sub>A</sub> = -40°C to +85°C			±10	
Logarithmic Slope (Scale Factor)	K	T <sub>A</sub> = +25°C		237.5	250	262.5	mV/
		T <sub>A</sub> = -40°C to +85°C		231.25		268.75	decade
Logarithmic Slope (Scale Factor) Temperature Drift		T <sub>A</sub> = -40°C to +85°C			80		μV/ decade/ °C
Input Offset Voltage	V <sub>IO</sub>	T <sub>A</sub> = +25°C,  V <sub>CMVIN</sub> - V <sub>REFIIN</sub>  ,  V <sub>CMVIN</sub> - V <sub>LOGIIN</sub>			1	5	mV
Input Offset Voltage Temperature Drift	V <sub>IOS</sub>	V <sub>CMVIN</sub> - V <sub>REFIIN</sub>  ,  V <sub>CMVIN</sub> - V <sub>LOGIIN</sub>			6		μV/°C
Voltage Reference Output	V <sub>REFVOUT</sub>	T <sub>A</sub> = +25°C		1.218	1.238	1.258	V
		T <sub>A</sub> = -40°C to +85°C (Note 4)		1.195		1.275	
Voltage Reference Output Current	I <sub>REFVOUT</sub>				1		mA
Current Reference Output Voltage	V <sub>REFISET</sub>	T <sub>A</sub> = +25°C		490	500	510	mV
		T <sub>A</sub> = -40°C to +85°C (Note 4)		482		518	
LOGV2 BUFFER							
Input Offset Voltage	V <sub>IO</sub>	T <sub>A</sub> = +25°C			0.4	2	mV
		T <sub>A</sub> = -40°C to +85°C (Note 4)				6	
Input Bias Current	I <sub>B</sub>	(Note 4)			0.01	1	nA
Output Voltage Range	V <sub>OH</sub>	R <sub>L</sub> to GND = 2kΩ			V <sub>CC</sub> - 0.2	V <sub>CC</sub> - 0.3	V
	V <sub>OL</sub>	R <sub>L</sub> to GND = 2kΩ		V <sub>EE</sub> + 0.2	V <sub>EE</sub> + 0.08		
Output Short-Circuit Current	I <sub>OUT+</sub>	Sourcing			34		mA
	I <sub>OUT-</sub>	Sinking			58		
Slew Rate	SR				12		V/μs
Unity-Gain Bandwidth	GBW				5		MHz

# Precision Transimpedance Logarithmic Amplifier with Over 5 Decades of Dynamic Range

## AC ELECTRICAL CHARACTERISTICS—Dual-Supply Operation

( $V_{CC} = +5V$ ,  $V_{EE} = -5V$ ,  $GND = 0$ ,  $I_{REF} = 1\mu A$ ,  $I_{LOG} = 10\mu A$ ,  $LOGV2 = SCALE$ ,  $LOGV1 = OSADJ$ ,  $CMVIN = CMVOUT$ ,  $R_{SET} > 1M\Omega$ ,  $T_A = +25^\circ C$ , unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
LOGV2 Total Noise		0.1Hz to 10Hz, total output-referred noise, $I_{REF} = 10nA$ , $I_{LOG} = 100nA$		17		$\mu V_{RMS}$
LOGV2 Spot Noise Density		$f = 5kHz$ , $I_{REF} = 10nA$ , $I_{LOG} = 100nA$		0.8		$\mu V/\sqrt{Hz}$
REFVOUT Total Noise		1Hz to 10Hz, total output-referred noise		3.3		$\mu V_{RMS}$
REFVOUT Spot Noise Density		$f = 5kHz$		266		$nV/\sqrt{Hz}$
REFISET Total Noise		1Hz to 10Hz, total output-referred noise		0.67		$\mu V_{RMS}$
REFISET Spot Noise Density		$f = 5kHz$		23		$nV/\sqrt{Hz}$
Small-Signal Unity-Gain Bandwidth		$I_{REF} = 1\mu A$ , $I_{LOG} = 10\mu A$ , $R_{COMP} = 300\Omega$ , $C_{COMP} = 32pF$		1		MHz

**Note 1:** All devices are 100% production tested at  $T_A = +25^\circ C$ . All temperature limits are guaranteed by design.

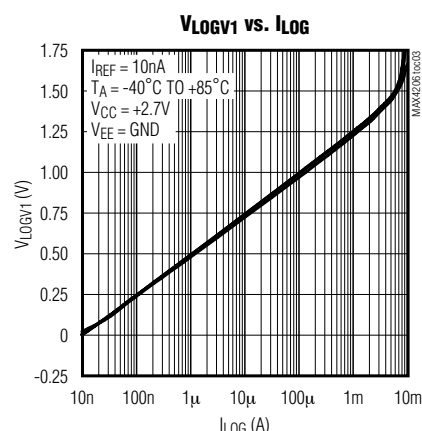
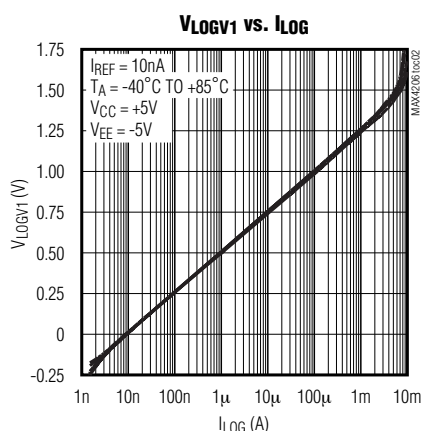
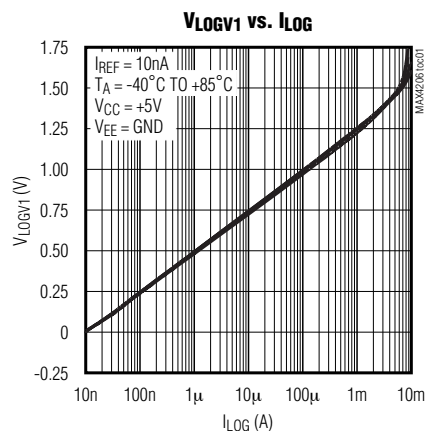
**Note 2:** Guaranteed and functionally verified.

**Note 3:** Log conformity error less than  $\pm 5mV$  with scale factor =  $0.25V/decade$ .

**Note 4:** Guaranteed by design.

## Typical Operating Characteristics

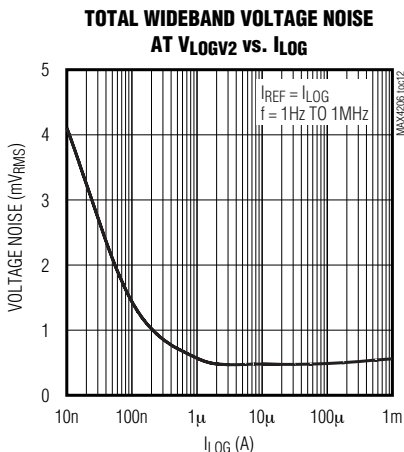
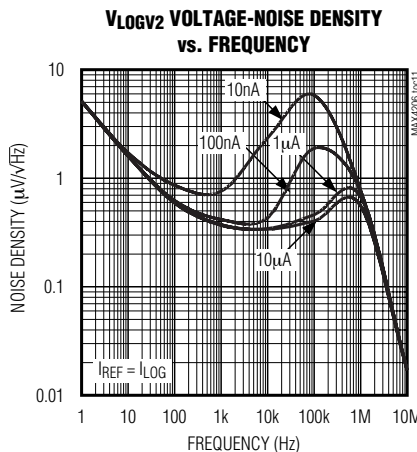
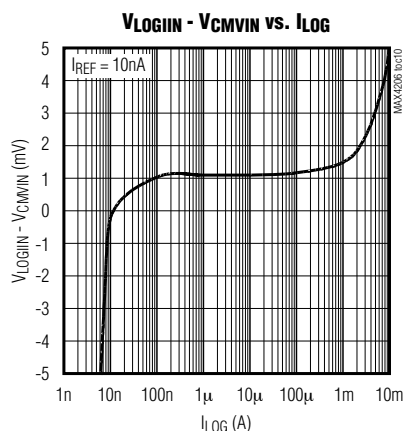
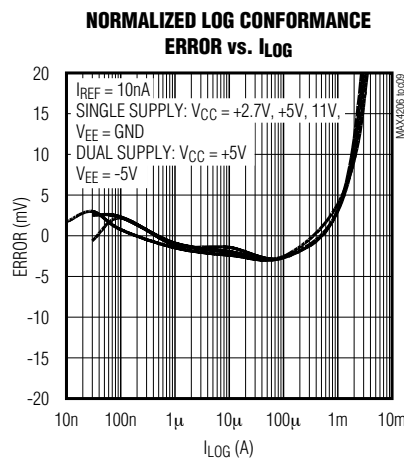
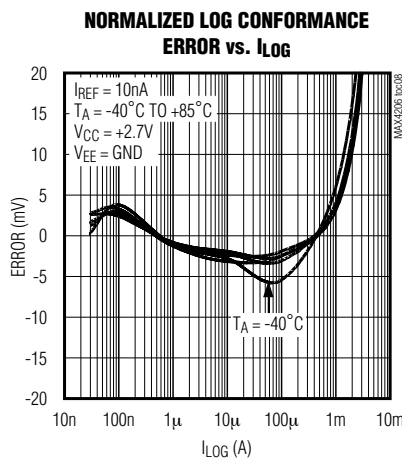
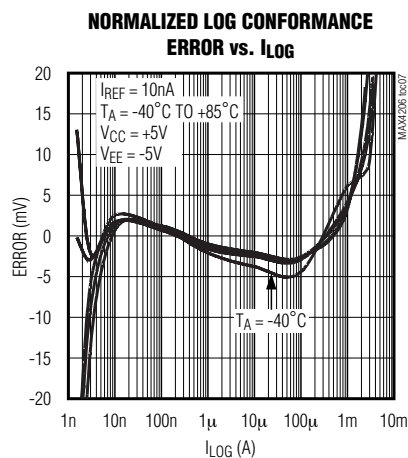
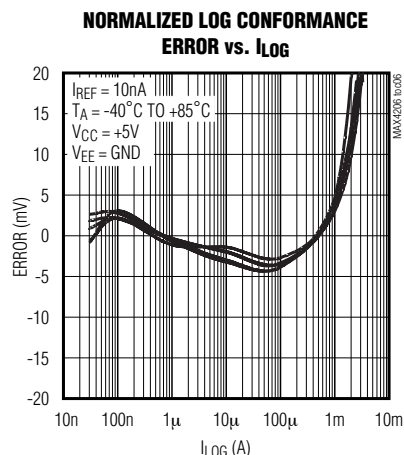
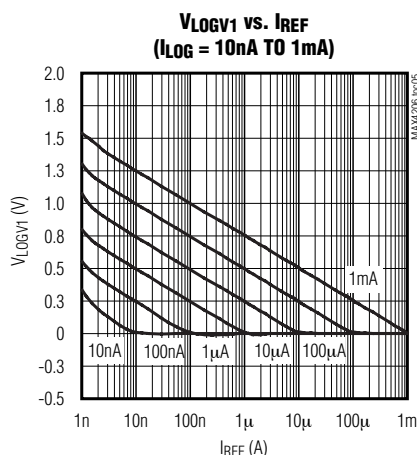
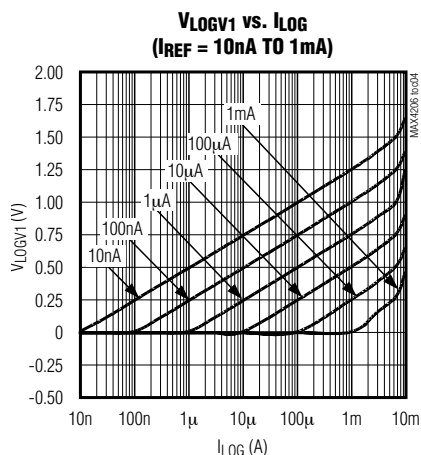
( $V_{CC} = +5V$ ,  $V_{EE} = GND = 0V$ ,  $I_{REF} = 1\mu A$ ,  $I_{LOG} = 10\mu A$ ,  $LOGV2 = SCALE$ ,  $LOGV1 = OSADJ$ ,  $CMVIN = CMVOUT$ ,  $R_{SET} > 1M\Omega$ ,  $T_A = +25^\circ C$ , unless otherwise noted.)



# Precision Transimpedance Logarithmic Amplifier with Over 5 Decades of Dynamic Range

## Typical Operating Characteristics (continued)

( $V_{CC} = +5V$ ,  $V_{EE} = GND = 0V$ ,  $I_{REF} = 1\mu A$ ,  $I_{LOG} = 10\mu A$ ,  $LOGV2 = SCALE$ ,  $LOGV1 = OSADJ$ ,  $CMVIN = CMVOUT$ ,  $R_{SET} > 1M\Omega$ ,  $T_A = +25^\circ C$ , unless otherwise noted.)

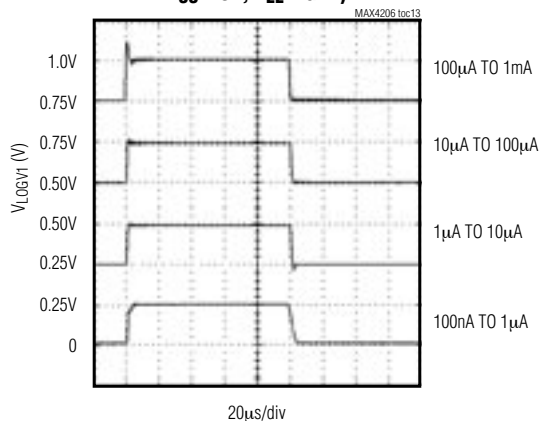


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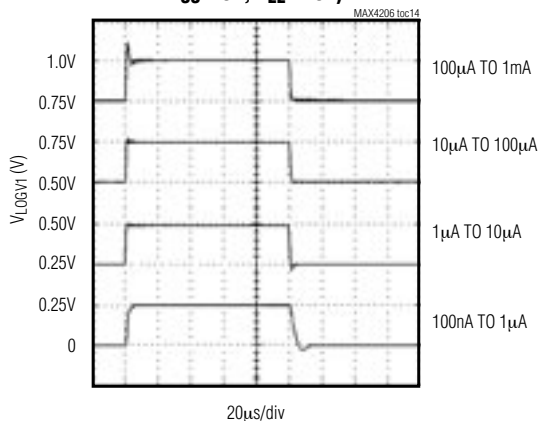
## Typical Operating Characteristics (continued)

( $V_{CC} = +5V$ ,  $V_{EE} = GND = 0V$ ,  $I_{REF} = 1\mu A$ ,  $I_{LOG} = 10\mu A$ ,  $LOGV2 = SCALE$ ,  $LOGV1 = OSADJ$ ,  $CMVIN = CMVOUT$ ,  $R_{SET} > 1M\Omega$ ,  $T_A = +25^\circ C$ , unless otherwise noted.)

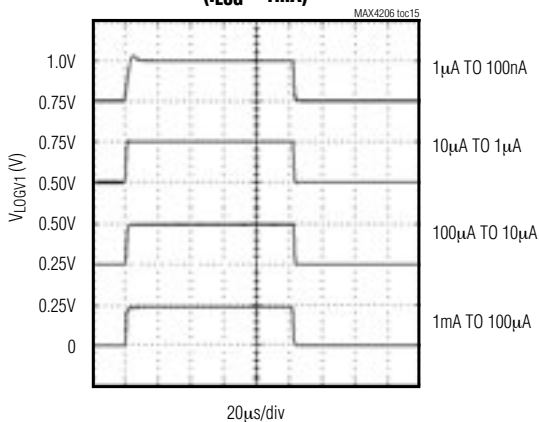
**$I_{LOG}$  PULSE RESPONSE**  
( $I_{REF} = 100nA$ ,  
 $V_{CC} = 5V$ ,  $V_{EE} = GND$ )



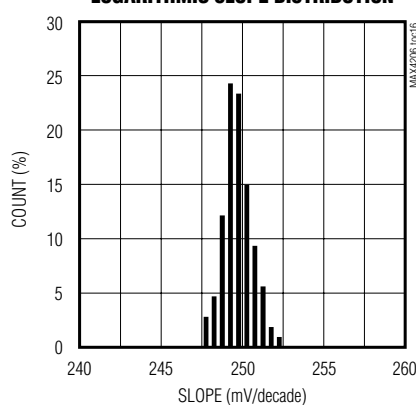
**$I_{LOG}$  PULSE RESPONSE**  
( $I_{REF} = 100nA$ ,  
 $V_{CC} = 5V$ ,  $V_{EE} = -5V$ )



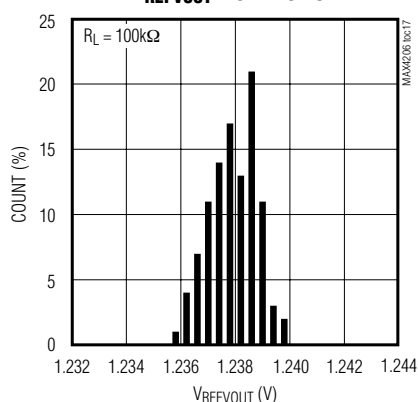
**$I_{REF}$  PULSE RESPONSE**  
( $I_{LOG} = 1mA$ )



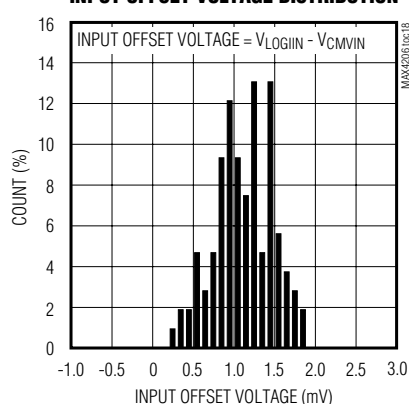
**LOGARITHMIC SLOPE DISTRIBUTION**



**$V_{REFVOUT}$  DISTRIBUTION**



**INPUT OFFSET VOLTAGE DISTRIBUTION**

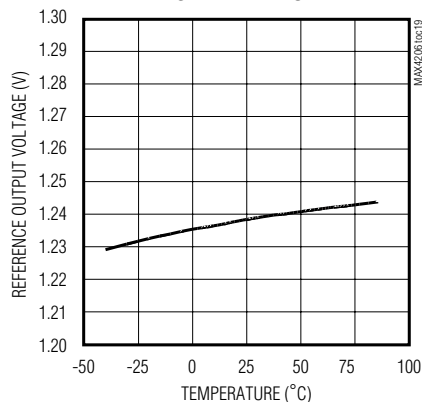


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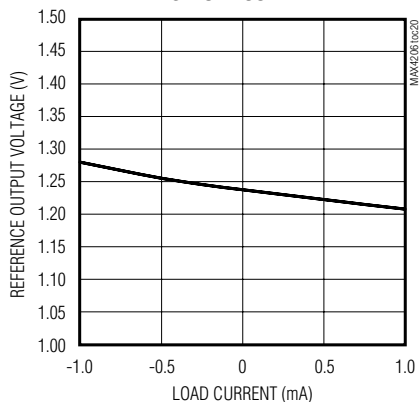
## Typical Operating Characteristics (continued)

( $V_{CC} = +5V$ ,  $V_{EE} = GND = 0V$ ,  $I_{REF} = 1\mu A$ ,  $I_{LOG} = 10\mu A$ ,  $LOGV2 = SCALE$ ,  $LOGV1 = OSADJ$ ,  $CMVIN = CMVOUT$ ,  $R_{SET} > 1M\Omega$ ,  $T_A = +25^\circ C$ , unless otherwise noted.)

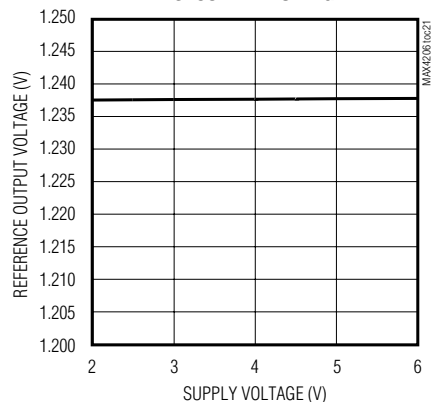
REFERENCE OUTPUT VOLTAGE ( $V_{REFVOUT}$ )  
vs. TEMPERATURE



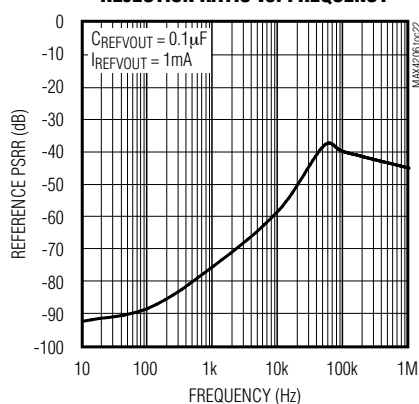
REFERENCE OUTPUT VOLTAGE ( $V_{REFVOUT}$ )  
vs. LOAD CURRENT



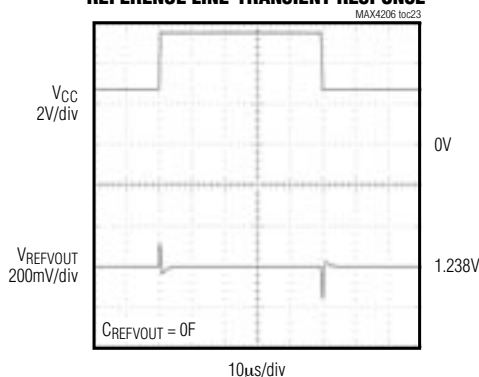
REFERENCE OUTPUT VOLTAGE ( $V_{REFVOUT}$ )  
vs. SUPPLY VOLTAGE



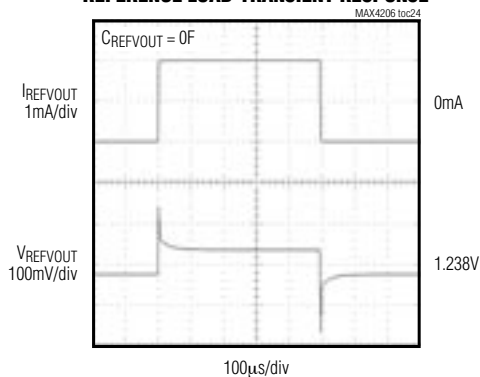
REFERENCE POWER-SUPPLY  
REJECTION RATIO vs. FREQUENCY



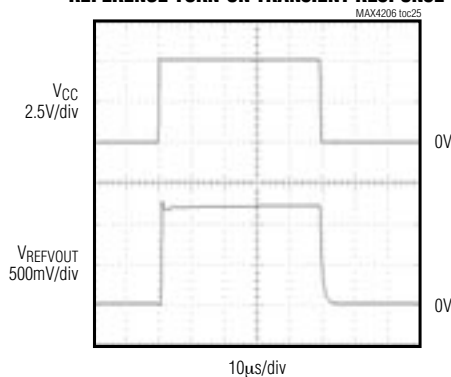
REFERENCE LINE-TRANSIENT RESPONSE



REFERENCE LOAD-TRANSIENT RESPONSE



REFERENCE TURN-ON TRANSIENT RESPONSE

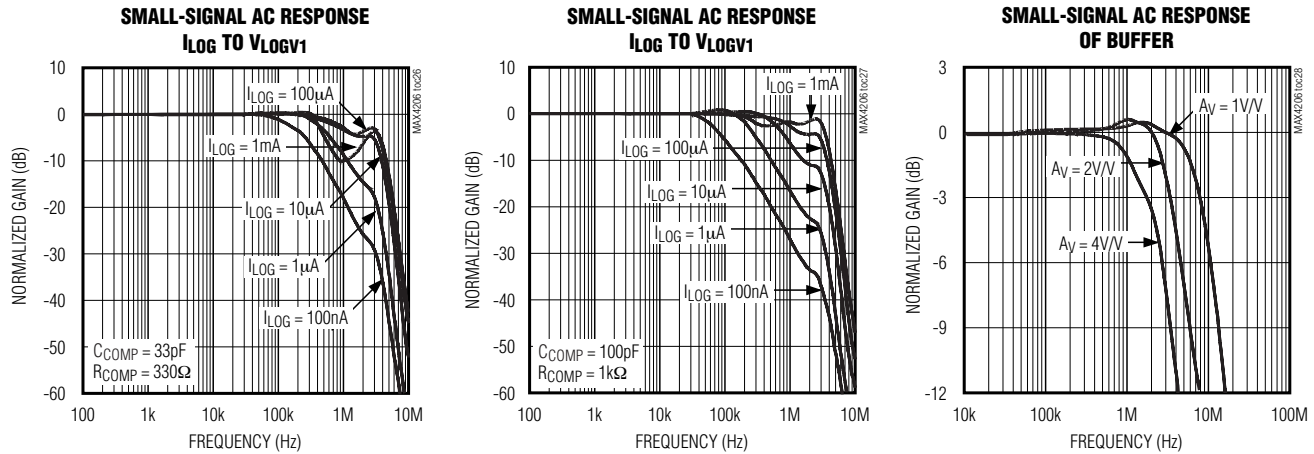




# Precision Transimpedance Logarithmic Amplifier with Over 5 Decades of Dynamic Range

## Typical Operating Characteristics (continued)

( $V_{CC} = +5V$ ,  $V_{EE} = GND = 0V$ ,  $I_{REF} = 1\mu A$ ,  $I_{LOG} = 10\mu A$ ,  $LOGV2 = SCALE$ ,  $LOGV1 = OSADJ$ ,  $CMVIN = CMVOUT$ ,  $R_{SET} > 1M\Omega$ ,  $T_A = +25^\circ C$ , unless otherwise noted.)



## Pin Description

PIN	NAME	FUNCTION
1, 9	N.C.	No Connection. Not internally connected.
2	REFVOUT	1.238V Reference Voltage Output. Bypass REFVOUT to GND with a 0 to $1\mu F$ capacitor (optional).
3	GND	Ground
4	$V_{EE}$	Negative Power Supply. Bypass $V_{EE}$ to GND with a $0.1\mu F$ capacitor.
5	LOGV1	Logarithmic Amplifier Voltage Output 1. The output scale factor of LOGV1 is $0.25V/decade$ .
6	OSADJ	Offset Adjust Input. When operating from a single power supply, current applied to OSADJ adjusts the output offset voltage (see the <i>Output Offset</i> section).
7	SCALE	Scale Factor Input. Adjust the output scale factor for LOGV2 using a resistive divider (see the <i>Scale Factor</i> section).
8	LOGV2	Logarithmic Amplifier Voltage Output 2. Adjust the output scale factor for LOGV2 using a resistive divider (see the <i>Scale Factor</i> section).
10	$V_{CC}$	Positive Power Supply. Bypass $V_{CC}$ to GND with a $0.1\mu F$ capacitor.
11	REFISET	Current Reference Adjust Input. A resistor, $R_{SET}$ , from REFISET to GND adjusts the current at REFIOU (see the <i>Adjusting the Logarithmic Intercept</i> section).
12	CMVOUT	$0.5V$ Common-Mode Voltage Reference Output. Bypass CMVOUT to GND with a $0.1\mu F$ capacitor.
13	REFIOU	Current Reference Output. The internal current reference output is available at REFIOU.
14	REFIIN	Current Reference Input. Apply an external reference current at REFIIN. $I_{REFIIN}$ is the reference current used by the logarithmic amplifier when generating LOGV1.
15	LOGIIN	Current Input to Logarithmic Amplifier. LOGIIN is typically connected to a photodiode anode or other external current source.
16	CMVIN	Common-Mode Voltage Input. $V_{CMVIN}$ is the common-mode voltage for the input and reference amplifiers (see the <i>Common Mode</i> section).

# Precision Transimpedance Logarithmic Amplifier with Over 5 Decades of Dynamic Range

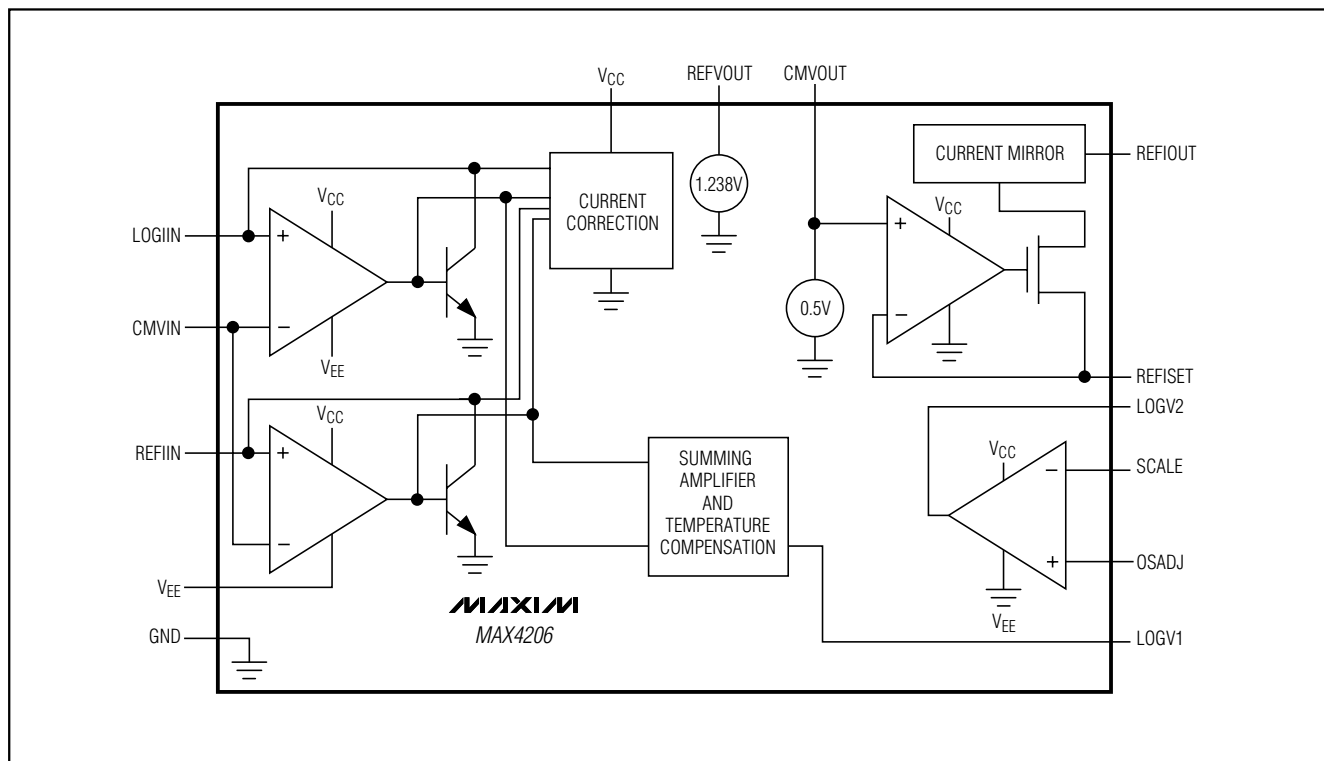


Figure 1. Functional Diagram

## Detailed Description

### Theory

Figure 2 shows a simplified model of a logarithmic amplifier. Two transistors convert the currents applied at LOGVIN and REFIN to logarithmic voltages according to the following equation:

$$V_{BE} = \left( \frac{kT}{q} \right) \ln \left( \frac{I_C}{I_S} \right)$$

where:

$V_{BE}$  = base-emitter voltage of a bipolar transistor

$k = 1.381 \times 10^{-23}$  J/K

$T$  = absolute temperature (K)

$q = 1.602 \times 10^{-19}$  C

$I_C$  = collector current

$I_S$  = reverse saturation current

The logarithmic amplifier compares  $V_{BE1}$  to the reference voltage  $V_{BE2}$ , which is a logarithmic voltage for a known reference current,  $I_{REF}$ . The temperature depen-

dencies of a logarithmic amplifier relate to the thermal voltage,  $(KT/q)$ , and  $I_S$ . Matched transistors eliminate the  $I_S$  temperature dependence of the amplifier in the following manner:

$$\begin{aligned} V_{OUT} &= V_{BE1} - V_{BE2} \\ &= \left( \frac{kT}{q} \right) \ln \left( \frac{I_{LOG}}{I_S} \right) - \left( \frac{kT}{q} \right) \ln \left( \frac{I_{REF}}{I_S} \right) \\ &= \left( \frac{kT}{q} \right) \left[ \ln \left( \frac{I_{LOG}}{I_S} \right) - \ln \left( \frac{I_{REF}}{I_S} \right) \right] \\ &= \left( \frac{kT}{q} \right) \left[ \ln \left( \frac{I_{LOG}}{I_{REF}} \right) \right] \\ &= \left( \frac{kT}{q} \right) (\ln(10)) \left[ \log_{10} \left( \frac{I_{LOG}}{I_{REF}} \right) \right] \\ &= K \times \log_{10} \left( \frac{I_{LOG}}{I_{REF}} \right) \end{aligned}$$

(see Figure 3)

# Precision Transimpedance Logarithmic Amplifier with Over 5 Decades of Dynamic Range

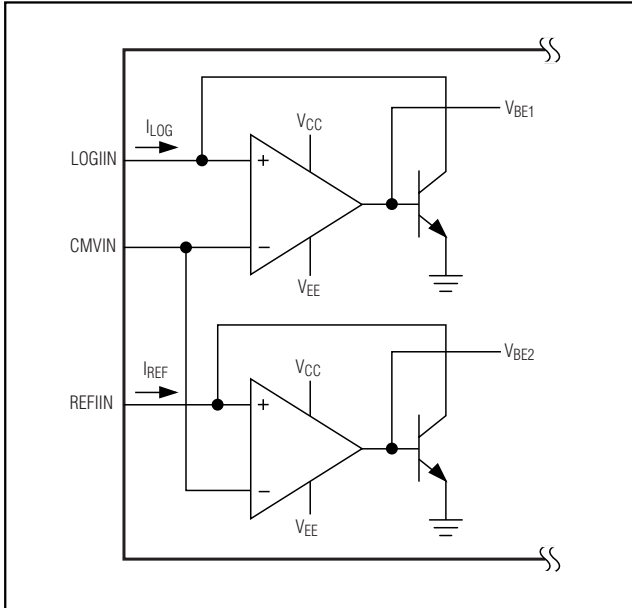


Figure 2. Simplified Model of a Logarithmic Amplifier

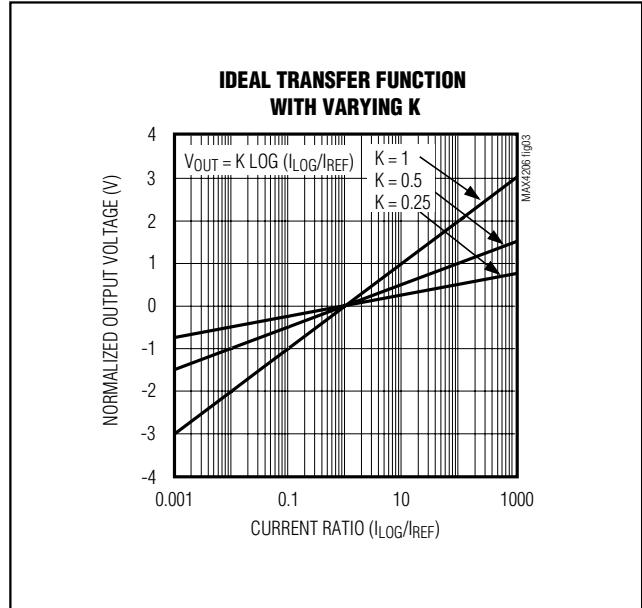


Figure 3. Ideal Transfer Function with Varying K

where:

$K$  = scale factor (V/decade)

$I_{LOG}$  = the input current at LOGIIN

$I_{REF}$  = the reference current at REFIIN

The MAX4206 uses internal temperature compensation to virtually eliminate the effects of the thermal voltage,  $(kT/q)$ , on the amplifier's scale factor, maintaining a constant slope over temperature.

## Definitions

### Transfer Function

The ideal logarithmic amplifier transfer function is:

$$V_{IDEAL} = K \times \log_{10} \left( \frac{I_{LOG}}{I_{REF}} \right)$$

Adjust  $K$  (see the *Scale Factor* section) to increase the transfer-function slope as illustrated in Figure 3. Adjust  $I_{REF}$  using REFISSET (see the *Adjusting the Logarithmic Intercept* section) to shift the logarithmic intercept to the left or right as illustrated in Figure 4.

### Log Conformity

Log conformity is the maximum deviation of the MAX4206's output from the best-fit straight line of the  $V_{LOGV1}$  versus  $\log(I_{LOG}/I_{REF})$  curve. It is expressed as a percent of the full-scale output or an output voltage.

### Referred-to-Input and Referred-to-Output Errors

The log nature of the MAX4206 insures that any additive error at LOGV1 corresponds to multiplicative error at the input, regardless of input level.

### Total Error

Total error, TE, is defined as the deviation of the output voltage,  $V_{LOGV1}$ , from the ideal transfer function (see the *Ideal Transfer Function* section):

$$V_{LOGV1} = V_{IDEAL} \pm TE$$

Total error is a combination of the associated gain, input offset current, input bias current, output offset voltage, and transfer characteristic nonlinearity (log conformity) errors:

$$V_{LOGV2} = K(1 \pm \Delta K) \left[ \log_{10} \left( \frac{I_{LOG} - I_{BIAS1}}{I_{REF} - I_{BIAS2}} \right) \pm 4(\pm V_{LC} \pm V_{OSOUT}) \right]$$

where  $V_{LC}$  and  $V_{OSOUT}$  are the log conformity and output offset voltages, respectively. Output offset is defined as the offset occurring at the output of the MAX4206 when equal currents are presented to  $I_{LOG}$  and  $I_{REF}$ . Because the MAX4206 is configured with a gain of  $K = 0.25V/decade$ , a 4 should multiply the  $(\pm V_{LC} \pm V_{OSOUT})$  term, if  $V_{LC}$  and  $V_{OSOUT}$  were derived from this default configuration.

# Precision Transimpedance Logarithmic Amplifier with Over 5 Decades of Dynamic Range

$I_{BIAS1}$  and  $I_{BIAS2}$  are currents on the order of 20pA, significantly smaller than  $I_{LOG}$  and  $I_{REF}$ , and can therefore be eliminated:

$$V_{LOGV2} \approx K(1 \pm \Delta K) \left[ \log_{10} \left( \frac{I_{LOG}}{I_{REF}} \right) \pm 4(\pm V_{LC} \pm V_{OSOUT}) \right]$$

Expanding this expression:

$$V_{LOGV2} \approx K \log_{10} \left( \frac{I_{LOG}}{I_{REF}} \right) \pm K \Delta K \log_{10} \left( \frac{I_{LOG}}{I_{REF}} \right) \pm 4K(1 \pm \Delta K)(\pm V_{LC} \pm V_{OSOUT})$$

The first term of this expression is the ideal component of  $V_{LOGV1}$ . The remainder of the expression is the total error, TE:

$$TE \approx \pm K \Delta K \log_{10} \left( \frac{I_{LOG}}{I_{REF}} \right) \pm 4K(1 \pm \Delta K)(\pm V_{LC} \pm V_{OSOUT})$$

In the second term, one can generally remove the products relating to  $\Delta K$ , because  $\Delta K$  is generally much less than 1. Hence, a good approximation for TE is given by:

$$TE \approx \pm K \left[ \Delta K \log_{10} \left( \frac{I_{LOG}}{I_{REF}} \right) \pm 4(\pm V_{LC} \pm V_{OSOUT}) \right]$$

As an example, consider the following situation:

Full-scale input = 5V

$I_{LOG} = 100\mu A$

$I_{REF} = 100nA$

$K = 1 \pm 5\%$  V/decade (note that the uncommitted amplifier is configured for a gain of 4)

$V_{LC} = \pm 5mV$  (obtained from the *Electrical Characteristics* table)

$V_{OSOUT} = \pm 2mV$  (typ)

$T_A = +25^\circ C$

Substituting into the total error approximation,

$$TE \approx \pm (1V/decade)(0.05 \log_{10} (100\mu A/100nA) \pm 4(\pm 5mV \pm 2mV) = \pm [0.15V \pm 4(\pm 7mV)]$$

As a worst case, one finds  $TE \approx \pm 178mV$  or  $\pm 3.6\%$  of full scale.

When expressed as a voltage, TE increases in proportion with an increase in gain as the contributing errors are defined at a specific gain. Calibration using a look-up table eliminates the effects of gain and output offset errors, leaving conformity error as the only factor con-

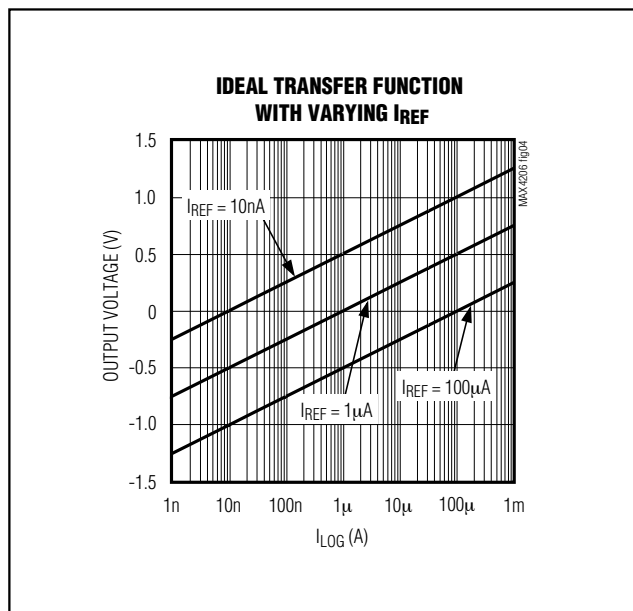


Figure 4. Ideal Transfer Function with Varying  $I_{REF}$

tributing to total error. For further accuracy, consider temperature monitoring as part of the calibration process.

## Applications Information

### Input Current Range

Five decades of input current across a 10nA to 1mA range are acceptable for  $I_{LOG}$  and  $I_{REF}$ . The effects of leakage currents increase as  $I_{LOG}$  and  $I_{REF}$  fall below 10nA. Bandwidth decreases at low  $I_{LOG}$  values (see the *Frequency Response and Noise Considerations* section). As  $I_{LOG}$  and  $I_{REF}$  increase to 1mA or higher, transistors become less logarithmic in nature. The MAX4206 incorporates leakage current compensation and high-current correction circuits to compensate for these errors.

### Frequency Compensation

The MAX4206's frequency response is a function of the input current magnitude and the selected compensation network at LOGIIN and REFIIN. The compensation network comprised of CCOMP and RCOMP ensures stability over the specified range of input currents by introducing an additional pole/zero to the system. For the typical application, select CCOMP = 100pF and RCOMP = 100Ω. Where high bandwidth at low current is required, CCOMP = 32pF and RCOMP = 330Ω are suitable compensation values.

# Precision Transimpedance Logarithmic Amplifier with Over 5 Decades of Dynamic Range

## Frequency Response and Noise Considerations

The MAX4206 bandwidth is proportional to the magnitude of the  $I_{REF}$  and  $I_{LOG}$  currents, whereas the noise is inversely proportional to  $I_{REF}$  and  $I_{LOG}$  currents.

## Common Mode

A common-mode input voltage,  $V_{CMVOUT}$ , of 0.5V is available at  $CMVOUT$  and can be used to bias the logging and reference amplifier inputs by connecting  $CMVOUT$  to  $CMVIN$ . An external voltage between 0.5V and 1V can be applied to  $CMVIN$  to bias the logging and reference transistor collectors and to optimize the performance required for both single- and dual-supply operation.

## Adjusting the Logarithmic Intercept

Adjust the logarithmic intercept by changing the reference current,  $I_{REF}$ . A resistor from  $REFSET$  to GND (see Figures 5 and 6) adjusts the reference current, according to the following equation:

$$R_{SET} = \frac{V_{REFSET}}{10 \times I_{REF}}$$

where  $V_{REFSET}$  is 0.5V. Select  $R_{SET}$  between 5k $\Omega$  and 5M $\Omega$ .  $REFIOUT$  current range is 10nA to 10 $\mu$ A only.

## Single-Supply Operation

When operating from a single +2.7V to +11V supply,  $I_{LOG}$  must be greater than  $I_{REF}$ , resulting in a positive slope of the log output voltages,  $LOGV1$  and  $LOGV2$ . Bias the log and reference amplifiers by connecting  $CMVOUT$  to  $CMVIN$  or connecting an external voltage reference between 0.5V and 1V to  $CMVIN$ . For single-supply operation, connect  $V_{EE}$  to GND.

## Output Offset

Select  $R_{OS}$  and  $I_{OS}$  to adjust the output offset voltage (see Figure 5). The magnitude of the offset voltage is given by:

$$V_{OS} = R_{OS} \times I_{OSADJ}$$

## Scale Factor

The scale factor,  $K$ , is the slope of the logarithmic output. For the  $LOGV1$  amplifier,  $K = 0.25V/decade$ . When operating in a single-supply configuration, adjust the overall scale factor for the MAX4206 using the uncommitted  $LOGV2$  amplifier and the following equation, which refers to Figure 5:

$$R_2 = R_1 \left( \frac{K}{0.25} - 1 \right)$$

Select  $R_1$  between 1k $\Omega$  and 100k $\Omega$ , with an ideal value of 10k $\Omega$ . The noninverting amplifier ensures that the overall scale factor is greater than or equal to 0.25V/decade for single-supply operation.

## Design Example

Desired:

Single-Supply Operation

Logarithmic intercept: 100nA

Overall scale factor = 1V/decade

Because there is no offset current applied to the circuit ( $R_{OS} = 0\Omega$ ), the reference current,  $I_{REF}$ , equals the log intercept of 100 $\mu$ A. Therefore,

$$R_{SET} = \frac{0.5V}{10 \times 100nA} = 500k\Omega$$

Select  $R_1 = 10k\Omega$ :

$$R_2 = 10k\Omega \left( \frac{1V/V}{0.25} - 1 \right) = 30k\Omega$$

## Dual-Supply Operation

When operating from dual  $\pm 2.7$  to  $\pm 5.5V$  supplies, it is not required that  $I_{LOG}$  be greater than  $I_{REF}$ . A positive output voltage results at  $LOGV1$  when  $I_{LOG}$  exceeds  $I_{REF}$ . A negative output voltage results at  $LOGV1$  when  $I_{LOG}$  is less than  $I_{REF}$ . Bias the log and reference amplifiers by connecting  $CMVOUT$  to  $CMVIN$  or connect an external 0.5V to 1V reference to  $CMVIN$ . For dual-supply operation with  $CMVIN < 0.5V$ , refer to the MAX4207 data sheet.

## Output Offset

The uncommitted amplifier in the inverting configuration utilized by the MAX4206 facilitates large output-offset voltage adjustments when operated with dual supplies. The magnitude of the offset voltage is given by the following equation:

$$V_{OS} = V_{OSADJ} \left( 1 + \frac{R_2}{R_1} \right)$$

A resistive divider between  $REFVOUT$ ,  $OSADJ$ , and GND can be used to adjust  $V_{OSADJ}$  (see Figure 6).

$$V_{OSADJ} = V_{REFVOUT} \left( \frac{R_4}{R_3 + R_4} \right)$$

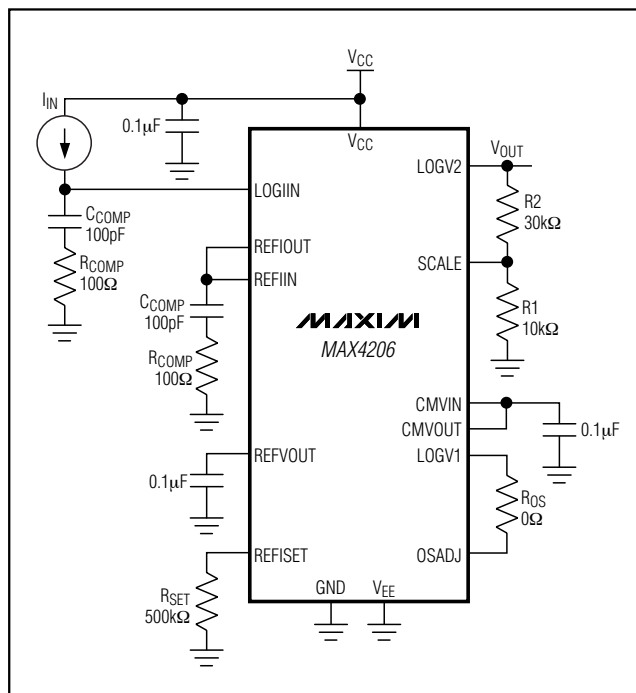


Figure 5. Single-Supply Typical Operating Circuit

### Scale Factor

The scale factor, K, is the slope of the logarithmic output. For the LOGV1 amplifier,  $K = 0.25\text{V/decade}$ . When operating from dual supplies, adjust the overall scale factor for the MAX4206 using the uncommitted LOGV2 amplifier and the following equation, which refers to Figure 6:

$$R_2 = R_1 \left( \frac{K}{0,25} \right)$$

Select  $R_2$  between  $1k\Omega$  and  $100k\Omega$ .

### ***Design Example***

Desired:

## Dual-Supply Operation

Logarithmic intercept: 1  $\mu$ A

Overall scale factor = 1V/decade

$$R_{SET} = \frac{0.5V}{10 \times 1\mu A} = 50k\Omega$$

Select  $R_1 = 10\text{k}\Omega$ :

$$R2 = 10k\Omega \times \left( \frac{1V/\text{decade}}{0.25} \right) = 40k\Omega$$

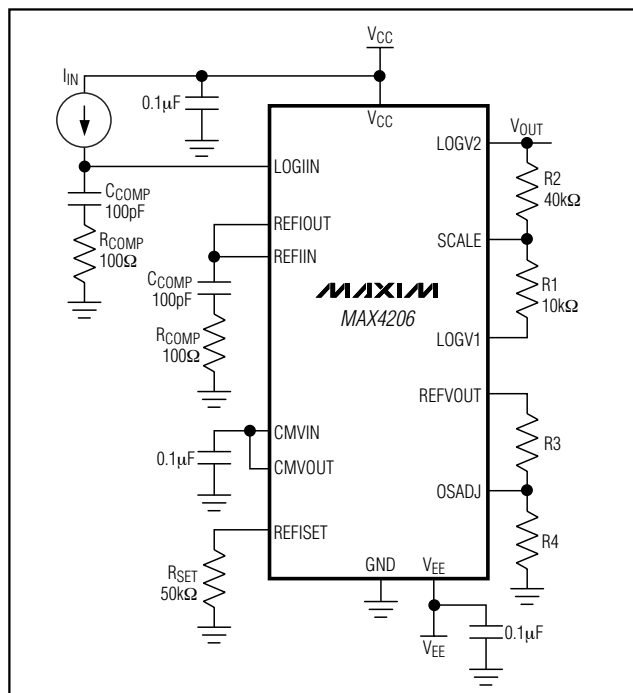


Figure 6. Dual-Supply Typical Operating Circuit

## Measuring Optical Absorbance

A photodiode provides a convenient means of measuring optical power, as diode current is proportional to the incident optical power. Measure absolute optical power using a single photodiode connected at LOGIIN, with the MAX4206's internal current reference driving REFIIN. Alternatively, connect a photodiode to each of the MAX4206's logging inputs, LOGIIN and REFIIN, to measure relative optical power (Figure 7).

In absorbance measurement instrumentation, a reference light source is split into two paths. The unfiltered path is incident upon the photodiode of the reference channel, REFIIN. The other path passes through a sample of interest, with the resulting filtered light incident on the photodiode of the second channel, LOGIIN. The MAX4206 outputs provide voltages proportional to the log ratio of the two optical powers—an indicator of the optical absorbance of the sample.

In wavelength-locking applications, often found in fiberoptic communication modules, two photodiode currents provide a means of determining whether a given optical channel is tuned to the desired optical frequency. In this application, two bandpass optical filters with overlapping “skirts” precede each photodiode. With proper filter selection, the MAX4206 output can vary monotonically (ideally linearly) with optical frequency.

# Precision Transimpedance Logarithmic Amplifier with Over 5 Decades of Dynamic Range

## Photodiode Current Monitoring

Figure 8 shows the MAX4206 in a single-supply, optical-power measurement circuit, common in fiberoptic applications. The MAX4007 current monitor converts the sensed APD current to an output current that drives the MAX4206 LOGIIN input (APD current is scaled by 0.1). The MAX4007 also buffers the high-voltage APD voltages from the lower MAX4206 voltages. The MAX4206's internal current reference sources 10nA ( $R_{SET} = 5M\Omega$ ) to the REFIIN input. This configuration sets the logarithmic intercept to 10nA, corresponding to an APD current of 100nA. The unity-gain configuration of the output buffer maintains the 0.25V/decade gain present at the LOGV1 output.

## Capacitive Loads

The MAX4206 drives capacitive loads of up to 50pF. Reactive loads decrease phase margin and can produce excessive ringing and oscillation. Use an isolation resistor in series with LOGV1 or LOGV2 to reduce the effect of large capacitive loads. Recall that the combination of the capacitive load and the small isolation resistor limits AC performance.

## Power Dissipation

The LOGV1 and LOGV2 amplifiers are capable of sourcing or sinking in excess of 30mA. Ensure that the continuous power dissipation rating for the MAX4206 is not exceeded.

## TQFN Package

The 16-lead thin QFN package has an exposed paddle that provides a heat-removal path, as well as excellent electrical grounding to the PC board. The MAX4206's exposed pad is internally connected to  $V_{EE}$ , and can either be connected to the PC board  $V_{EE}$  plane or left unconnected. Ensure that only  $V_{EE}$  traces are routed under the exposed paddle.

## Layout and Bypassing

Bypass  $V_{CC}$  and  $V_{EE}$  to GND with ceramic 0.1 $\mu$ F capacitors. Place the capacitors as close to the device as possible. Bypass REFVOUT and/or CMVOUT to GND with a 0.1 $\mu$ F ceramic capacitor for increased

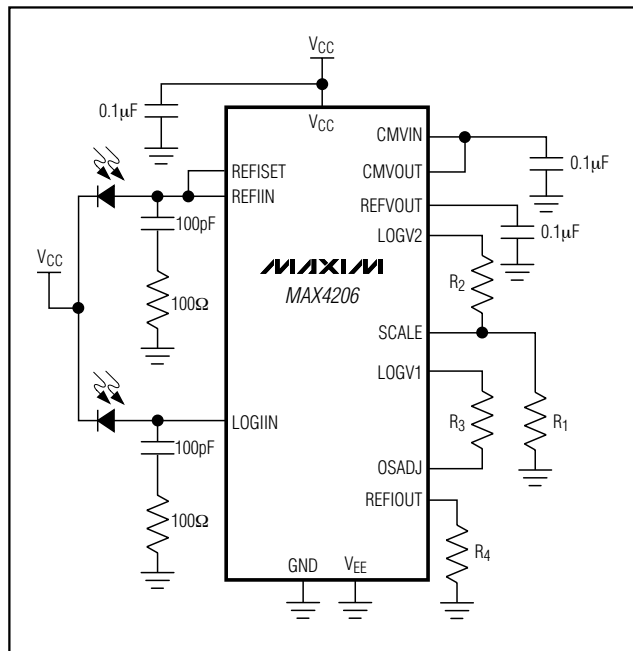


Figure 7. Measuring Optical Absorbance

noise immunity and a clean reference current. For low-current operation, it is recommended to use metal guard rings around LOGIIN, REFIIN, and REFISSET. Connect this guard ring to CMVOUT.

## Evaluation Kit

An evaluation kit is available for the MAX4206. The kit is flexible and can be configured for either single-supply or dual-supply operation. The scale factor and reference current are selectable. Refer to the MAX4206 Evaluation Kit data sheet for more information.

## Chip Information

TRANSISTOR COUNT: 754

PROCESS: BiCMOS



# Precision Transimpedance Logarithmic Amplifier with Over 5 Decades of Dynamic Range

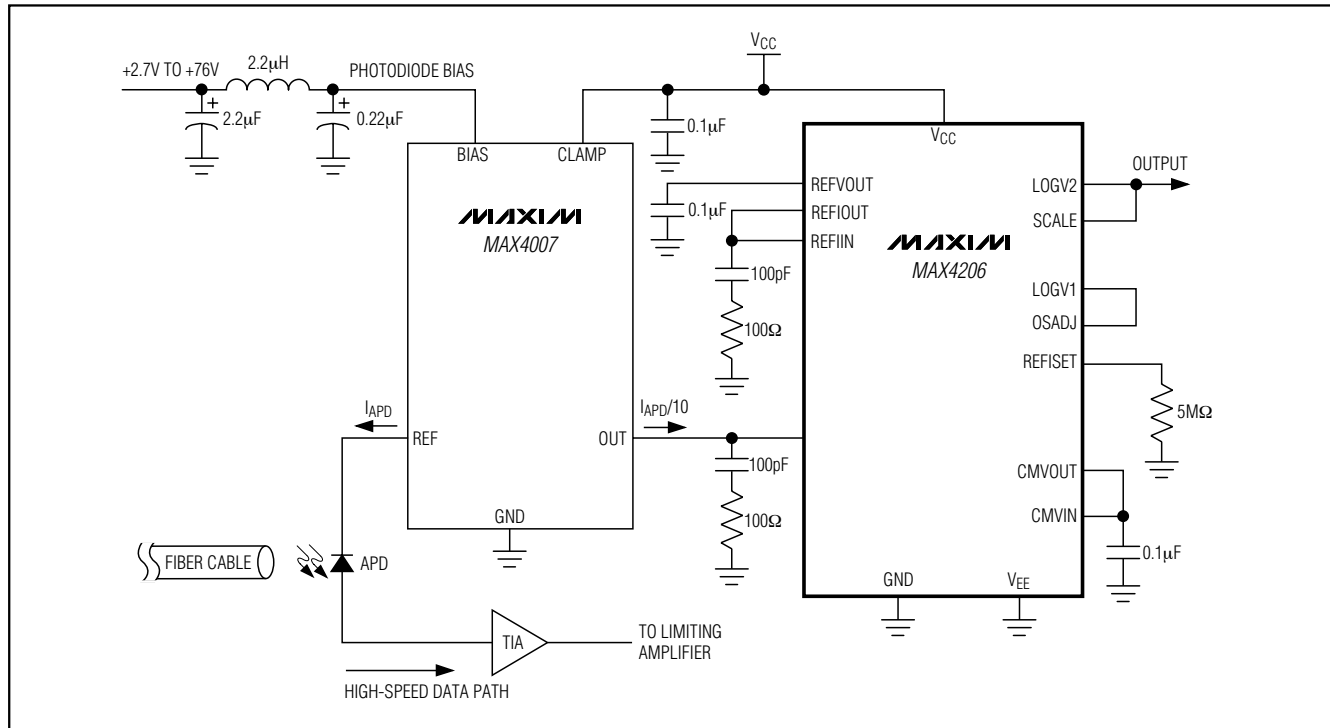


Figure 8. Logarithmic Current-Sensing Amplifier with Sourcing Input

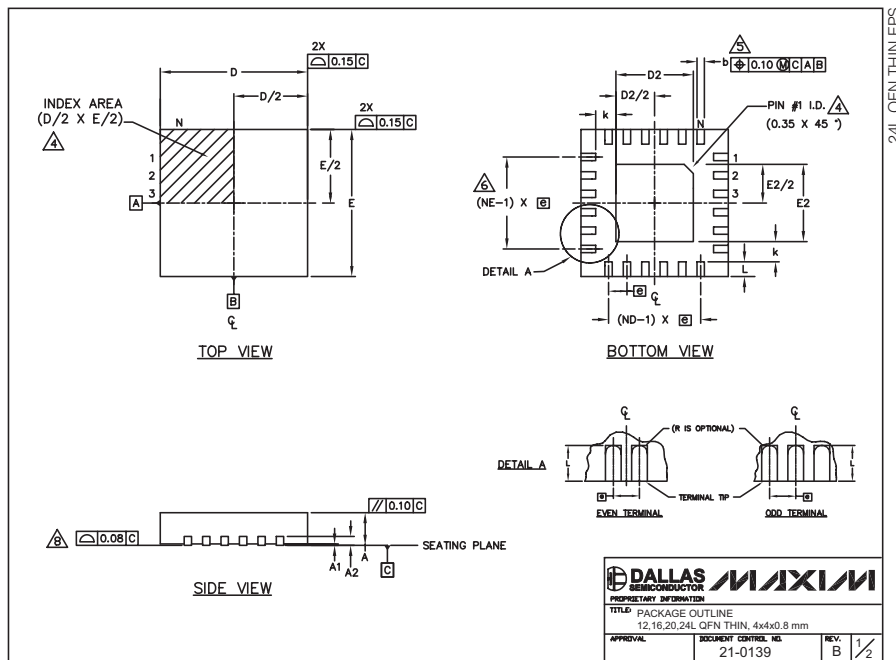


# Precision Transimpedance Logarithmic Amplifier with Over 5 Decades of Dynamic Range

## Package Information

(The package drawing(s) in this data sheet may not reflect the most current specifications. For the latest package outline information, go to [www.maxim-ic.com/packages](http://www.maxim-ic.com/packages).)

MAX4206



COMMON DIMENSIONS												
PKG	12L 4x4			16L 4x4			20L 4x4			24L 4x4		
REF.	MIN.	NDM.	MAX.	MIN.	NDM.	MAX.	MIN.	NDM.	MAX.	MIN.	NDM.	MAX.
A	0.70	0.75	0.80	0.70	0.75	0.80	0.70	0.75	0.80	0.70	0.75	0.80
A1	0.0	0.02	0.05	0.0	0.02	0.05	0.0	0.02	0.05	0.0	0.02	0.05
A2	0.20 REF			0.20 REF			0.20 REF			0.20 REF		
b	0.25	0.30	0.35	0.25	0.30	0.35	0.20	0.25	0.30	0.18	0.23	0.30
D	3.90	4.00	4.10	3.90	4.00	4.10	3.90	4.00	4.10	3.90	4.00	4.10
E	3.90	4.00	4.10	3.90	4.00	4.10	3.90	4.00	4.10	3.90	4.00	4.10
e	0.80 BSC.			0.65 BSC.			0.50 BSC.			0.50 BSC.		
k	0.25	-	-	0.25	-	-	0.25	-	-	0.25	-	-
L	0.45	0.55	0.65	0.45	0.55	0.65	0.45	0.55	0.65	0.30	0.40	0.50
N	12			16			20			24		
ND	3			4			5			6		
NE	3			4			5			6		
WGGC Var.	WGGB			WGGC			WGGD-1			WGGD-2		

EXPOSED PAD VARIATIONS								
PKG CODES	D2			E2				
	MIN.	NDM.	MAX.	MIN.	NDM.	MAX.		
T1244-2	1.95	2.10	2.25	1.95	2.10	2.25		
T1644-2	1.95	2.10	2.25	1.95	2.10	2.25		
T2044-1	1.95	2.10	2.25	1.95	2.10	2.25		
T2444-1	2.45	2.60	2.63	2.45	2.60	2.63		
T2444-2	1.95	2.10	2.25	1.95	2.10	2.25		

NOTES:

- DIMENSIONING & TOLERANCING CONFORM TO ASME Y14.5M-1994.
- ALL DIMENSIONS ARE IN MILLIMETERS. ANGLES ARE IN DEGREES.
- N IS THE TOTAL NUMBER OF TERMINALS.
- THE TERMINAL #1 IDENTIFIER AND TERMINAL NUMBERING CONVENTION SHALL CONFORM TO JEDEC 95-1 SPP-012. DETAILS OF TERMINAL #1 IDENTIFIER ARE OPTIONAL, BUT MUST BE LOCATED WITHIN THE ZONE INDICATED. THE TERMINAL #1 IDENTIFIER MAY BE EITHER A MOLD OR MARKED FEATURE.
- DIMENSION b APPLIES TO METALLIZED TERMINAL AND IS MEASURED BETWEEN 0.25 mm AND 0.30 mm FROM TERMINAL TIP.
- ND AND NE REFER TO THE NUMBER OF TERMINALS ON EACH D AND E SIDE RESPECTIVELY.
- DEPOPULATION IS POSSIBLE IN A SYMMETRICAL FASHION.
- COPLANARITY APPLIES TO THE EXPOSED HEAT SINK SLUG AS WELL AS THE TERMINALS.
- DRAWING CONFORMS TO JEDEC MO220, EXCEPT FOR T2444-1.

**DALLAS SEMICONDUCTOR**

**MAXIM**

PROPRIETARY INFORMATION

TITLE: PACKAGE OUTLINE  
12,16,20,24L QFN THIN, 4x4x0.8 mm

APPROVAL: [ ] DOCUMENT CONTROL: 21-0139 REV: B 2/2

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